# The RF MOSFET Line Power Field Effect Transistor

## **N-Channel Enhancement-Mode MOSFET**

Designed primarily for wideband large-signal output and driver stages to 500 MHz.

- Push-Pull Configuration Reduces Even Numbered Harmonics
- Typical Performance at 400 MHz, 28 Vdc

Output Power = 40 Watts

Gain = 13 dB

Efficiency = 50%

• Typical Performance at 175 MHz, 28 Vdc

Output Power = 40 Watts

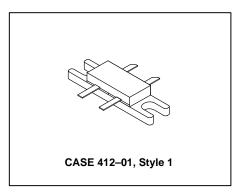
Gain = 17 dB

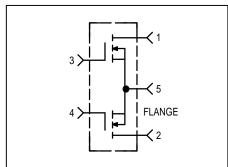
Efficiency = 60%

- Excellent Thermal Stability, Ideally Suited for Class A Operation
- Facilitates Manual Gain Control, ALC and Modulation Techniques
- 100% Tested for Load Mismatch at All Phase Angles with 30:1 VSWR
- Low C<sub>rss</sub> 4.5 pF @ V<sub>DS</sub> = 28 Volts
- Circuit board photomaster available upon request by contacting RF Tactical Marketing in Phoenix, AZ.

# **MRF166W**

40 W, 500 MHz TMOS BROADBAND RF POWER FET





#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-Gate Voltage	V <sub>DSS</sub>	65	Vdc
Drain–Gate Voltage (R <sub>GS</sub> = 1.0 M $\Omega$ )	V <sub>DGR</sub>	65	Vdc
Gate–Source Voltage	V <sub>GS</sub>	± 40	Adc
Drain Current — Continuous	ID	8.0	ADC
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	PD	175 1.0	Watts °C/W
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Operating Junction Temperature	TJ	200	°C

#### THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case	$R_{ heta JC}$	1.0	°C/W	]
---------------------------------------	----------------	-----	------	---

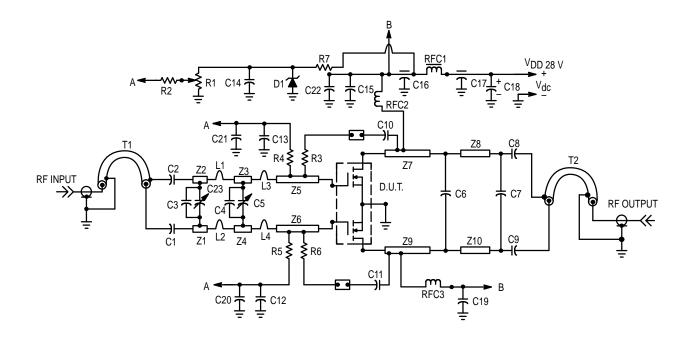
NOTE: Handling and Packaging — MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

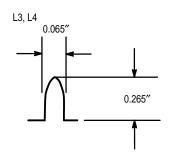


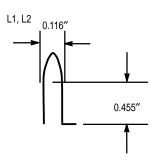
### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS (1)				•	
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 5.0 mA)	V(BR)DSS	65	_	_	Vdc
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc)	IDSS	_	_	1.0	mA
Gate-Source Leakage Current (V <sub>GS</sub> = 40 Vdc, V <sub>DS</sub> = 0 Vdc)	IGSS	_	_	1.0	μА
ON CHARACTERISTICS (1)					
Gate Threshold Voltage ( $V_{DS}$ = 10 Vdc, $I_D$ = 25 mA)	VGS(th)	1.0	3.0	6.0	Vdc
Forward Transconductance (V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 1.5 A)	9fs	600	800	_	mS
DYNAMIC CHARACTERISTICS (1)					
Input Capacitance ( $V_{DS} = 28 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz}$ )	C <sub>iss</sub>	_	30	_	pF
Output Capacitance (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc, f = 1.0 MHz)	C <sub>oss</sub>	_	35	_	pF
Reverse Transfer Capacitance (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc, f = 1.0 MHz)	C <sub>rss</sub>	_	4.5	_	pF
FUNCTIONAL CHARACTERISTICS (2)	•			•	•
Common Source Power Gain (V <sub>DD</sub> = 28 Vdc, P <sub>out</sub> = 40 W, f = 400 MHz, I <sub>DG</sub> = 100 mA)	G <sub>ps</sub>	11	13	_	dB
Drain Efficiency (V <sub>DD</sub> = 28 Vdc, P <sub>out</sub> = 40 W, f = 400 MHz, I <sub>DG</sub> = 100 mA)	η	45	50	_	%
Electrical Ruggedness (V <sub>DD</sub> = 28 Vdc, P <sub>out</sub> = 40 W, f = 400 MHz, I <sub>DG</sub> = 100 mA) Load VSWR = 30:1, All phase angles at frequency of test	Ψ	No Degradation in Output Power			

<sup>(1)</sup> Each transistor chip measured separately.(2) Both transistor chips operating in a push–pull amplifier.

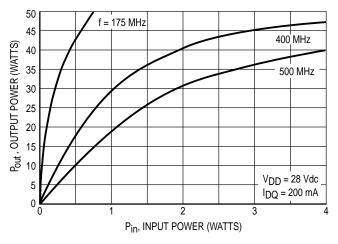






C1, C2, C8, C9,	270 pF, Chip Cap	RFC1	Ferroxcube VK-200-19/4B
C12, C13, C15	270 pr, Criip Cap	RFC2, RFC3	10T, ID = 1/4", 18 AWG
, ,	F C nF Chin Con	•	•
C3	5.6 pF, Chip Cap	R1	10 kΩ, 10T
C4	20 pF, Chip Cap	R2	9.2 kΩ, 1/2 W
C5	0 – 20 pF, Johanson*	R3, R6	330 Ω, 1.0 W
C6	8.2 pF, Chip Cap	R4 R5	520 Ω, 1/4 W
C7	15 pF, Chip Cap	R7	1.5 kΩ, 1/2 W
C10, C11, C14, C19,	0.01 μF	T1, T2	Balun 2.0", 50 Ω Semi–Rigid Coax
C20, C21, C22		Z1, Z2	0.120 x 0.467"
C16, C17	680 pF, Feedthru	Z3, Z4	0.120 x 0.55" *
C18	10 μF, 50 V	Z5, Z6	0.120 x 0.49"
C23	0 - 10 pF, Johanson*	Z7, Z9	0.120 x 0.85"
D1	IN5343 – Motorola Zener	Z8, Z10	0.120 x 0.6" for C6
L1, L2	Hair Pin Inductor #18 AWG,		
	0.065 W x 0.265 H	* C4, C5 Center	r of Z3 and Z4
L3, L4	Hair Pin Inductor #18 AWG,	Board Material – Teflon® Fiberglass	
	0.116 W x 0.445 H	Dielectric Thickness = 0.030". ε <sub>r</sub> = 2.55 Copper Clad. 2.0 oz. Copper	

Figure 1. MRF166 400 MHz Test Circuit Schematic





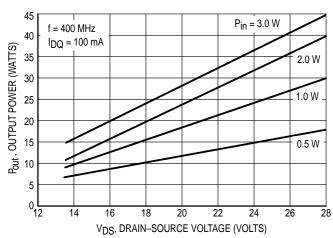


Figure 3. Output Power versus Voltage

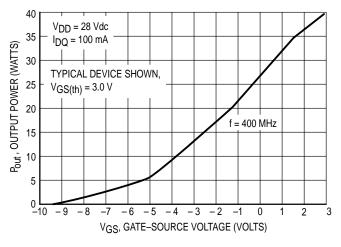


Figure 4. Output Power versus Gate Voltage

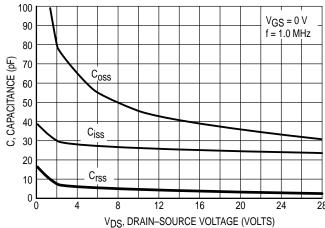
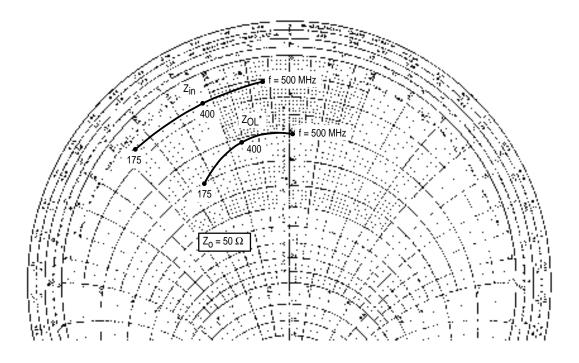


Figure 5. Capacitance versus Voltage



 $V_{DD}$  = 28 Vdc,  $I_{DQ}$  = 100 mA,  $P_{out}$  = 40 W

f MHz	Z <sub>in</sub> Ohms	Z <sub>OL</sub> * Ohms
175	3.7 - j 22.4	15.2 – j 16.6
400	3.6 - j 10.99	10.3 – j 7.99
500	2.6 - j 3.2	10.2 + j 0.5

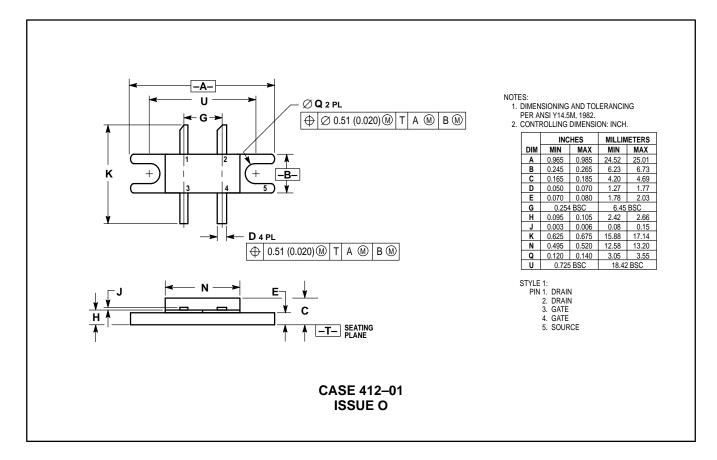
Table 1. Input and Output Impedances

 $Z_{OL}^{\star}$  = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage and frequency.

NOTE: Input and output impedance values given are measured from gate to gate and drain to drain respectively.

Figure 6. Series Equivalent Input/Output Impedance

#### PACKAGE DIMENSIONS



Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters can and do vary in different applications. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and

How to reach us:

**USA/EUROPE**: Motorola Literature Distribution; P.O. Box 20912; Phoenix, Arizona 85036. 1–800–441–2447

MFAX: RMFAX0@email.sps.mot.com – TOUCHTONE (602) 244–6609 INTERNET: http://Design-NET.com

JAPAN: Nippon Motorola Ltd.; Tatsumi-SPD-JLDC, Toshikatsu Otsuki, 6F Seibu-Butsuryu-Center, 3-14-2 Tatsumi Koto-Ku, Tokyo 135, Japan. 03-3521-8315

**HONG KONG**: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298



